## Notice of References Cited Application/Control No. 10/828,274 Independence of References Cited Applicant(s)/Patent Under Reexamination CHEN, YIN-HUNG Examiner Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS \* Document Number Date Name Classification

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,525,936 B2	02-2003	Beitelmal et al.	361/695
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	D	US-			
	Ε	US-			
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